



CERTIFICATE OF ACCREDITATION

The ANSI National Accreditation Board

Hereby attests that

SP Metrology System (Thailand) Co., Ltd.
69/29 Moo. 1 T. Klongsi A.Klongluang
Pathumthani, Thailand 12120

Fulfils the requirements of

ISO/IEC 17025:2017

In the fields of

CALIBRATION and DIMENSIONAL MEASUREMENT

This certificate is valid only when accompanied by a current scope of accreditation document.

The current scope of accreditation can be verified at www.anab.org.

A handwritten signature in black ink, appearing to read "R. Douglas Leonard Jr.".

R. Douglas Leonard Jr., VP, PILR SBU

Expiry Date: 16 May 2022

Certificate Number: ACT-2050



This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017.
This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).

SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017

SP Metrology System (Thailand) Co., Ltd.

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CALIBRATION AND DIMENSIONAL MEASUREMENT

Valid to: May 16, 2022

Certificate Number: ACT-2050

CALIBRATION

Acoustics and Vibration

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
¹ Sound Level Meter	94 dB 114 dB	0.15 dB 0.15 dB	Sound Level Calibrator

Chemical Quantities

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
^{1,2} pH Meter	4.01 pH 7.01 pH 10.01 pH	0.012 pH 0.012 pH 0.012 pH	pH Solution Buffer
^{1,2} Conductivity Meter	84 µS/cm 1 413 µS/cm 12 880 µS/cm	0.6 µS/cm 8.2 µS/cm 75 µS/cm	STD Conductivity Solution
¹ Refractometer	5 %Brix 10 %Brix 20 %Brix 30 %Brix 60 %Brix	0.075 %Brix 0.074 %Brix 0.074 %Brix 0.073 %Brix 0.072 %Brix	Sucrose Standard Solution
¹ Refractometer Refractive Index	1.340 27 nD 1.347 84 nD 1.363 85 nD 1.381 14 nD 1.441 89 nD	0.000 11 nD 0.000 11 nD 0.000 11 nD 0.000 11 nD 0.000 11 nD	Sucrose Standard Solution

Chemical Quantities

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
¹ Turbidity meter	20 NTU 200 NTU 750 NTU	0.12 NTU 1.2 NTU 5.8 NTU	Turbidity Standard Solution
¹ Viscometer Rotational @25°C	101.1 cP 6 618 cP 15 608 cP	0.16 cP 15 cP 36 cP	STD Viscosity Solution
¹ Total Dissolved Solids (TDS) Meter	1 000 mg/l	32 mg/l	TDS Solution

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
¹ RTD Temperature Indicator (Simulator) Temperature Indicator	RTD (Pt100) (-200 to 800) °C 10 Ω, Cu 427 (-100 to 260) °C	0.25 °C 0.42 °C	Fluke 744 Process Calibrator
¹ Thermocouple Temperature Indicator (Simulator) Temperature Indicator	Type E (-250 to 1 000) °C Type J (-210 to 1 200) °C Type K (-200 to 1 372) °C Type R and S (0 to 1 768) °C Type T (-250 to 400) °C	0.42 °C 0.45 °C 0.38 °C 0.96 °C 0.64 °C	Fluke 744 Process Calibrator
DC Voltage ¹ Source	Up to < 330 mV 330 mV to < 3.3 V (3.3 to < 33) V (33 to < 330) V (330 to 1 000) V	48 µV/V + 9 µV 40 µV/V + 60 µV 40 µV/V + 0.6 mV 45 µV/V + 6 mV 45 µV/V + 60 mV	Fluke 5502A Multiproduct Calibrator
DC Current ¹ Source	Up to < 3.3 mA (3.3 to < 33) mA (33 to < 330) mA (0.33 to < 1.1) A (1.1 to < 3) A (3.0 to < 11) A (11 to 20) A	0.08 mA/A + 0.085 µA 0.08 mA/A + 0.65 µA 0.08 mA/A + 7.8 µA 0.3 mA/A + 0.08 mA 0.3 mA/A + 0.085 mA 0.47 mA/A + 0.8 mA 0.78 mA/A + 5.8 mA	Fluke 5502A Multiproduct Calibrator

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Voltage ¹ Source	(1 to < 33) mV (10 to 45) Hz > 45 Hz to 10 kHz (> 10 to 20) kHz (> 20 to 50) kHz (> 50 to 100) kHz (> 100 to 450) kHz (33 to < 330) mV (10 to 45) Hz > 45 Hz to 10 kHz (> 10 to 20) kHz (> 20 to 50) kHz (> 50 to 100) kHz (> 100 to 450) kHz (0.33 to < 3.3) V (10 to 45) Hz > 45 Hz to 10 kHz (> 10 to 20) kHz (> 20 kHz to 50) kHz (> 50 kHz to 100) kHz (> 100 kHz to 450) kHz (3.3 to < 33) V (10 Hz to 45) Hz > 45 Hz to 10 kHz (> 10 kHz to 20) kHz (> 20 kHz to 50) kHz (> 50 kHz to 90) kHz (33 to < 330) V 45 Hz to 1 kHz (> 1 to 10) kHz (> 10 kHz to 18) kHz (330 to 1 000) V 45 Hz to 1 kHz (> 1 kHz to 5) kHz (> 5 kHz to 10) kHz	1.5 mV/V + 20 µV 0.8 mV/V + 20 µV 1.5 mV/V + 20 µV 1.6 mV/V + 20 µV 3 mV/V + 30 µV 8 mV/V + 50 µV 0.5 mV/V + 20 µV 0.25 mV/V + 20 µV 0.6 mV/V + 20 µV 0.8 mV/V + 35 µV 1.9 mV/V + 0.15 mV 4 mV/V + 0.3 mV 0.4 mV/V + 0.08 mV 0.25 mV/V + 0.1 mV 0.6 mV/V + 0.1 mV 0.8 mV/V + 0.1 mV 1.9 mV/V + 0.2 mV 4 mV/V + 0.8 mV 0.4 mV/V + 0.9 mV 0.25 mV/V + 0.8 mV 0.6 mV/V + 0.9 mV 0.8 mV/V + 0.9 mV 1.9 mV/V + 2 mV 0.4 mV/V + 7 mV 0.65 mV/V + 10 mV 0.7 mV/V + 15 mV 0.4 mV/V + 0.06 V 0.65 mV/V + 0.078 V 0.7 mV/V + 0.078 V	Fluke 5502A Multiproduct Calibrator

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Current ¹ Source	(0.029 to < 0.33) mA (20 Hz to 45) Hz > 45 Hz to 1 kHz (> 1 to 5) kHz (> 5 to 10) kHz (0.33 to < 3.3) mA (20 Hz to 45) Hz > 45 Hz to 1 kHz (> 1 to 5) kHz (> 5 to 10) kHz (3.3 to < 33) mA (20 Hz to 45 Hz) > 45 Hz to 1 kHz (> 1 to 5) kHz (> 5 to 10) kHz (33 to < 330) mA (20 Hz to 45) Hz > 45 Hz to 1 kHz (> 1 to 5) kHz (> 5 to 10) kHz (0.33 to < 1.1) A (20 to 45) Hz > 45 Hz to 1 kHz (> 1 to 5) kHz (1.1 to < 3) A (45 to 65) Hz (> 65 to 500) Hz > 500 Hz to 1 kHz (> 1 to 5) kHz (3.0 to < 11) A (45 to 65) Hz > 65 Hz to 1 kHz (11 to 20) A (45 to 65) Hz > 65 Hz to 1 kHz	1.6 mA/A + 0.08 µA 1 mA/A + 0.08 µA 2.4 mA/A + 0.12 µA 6.3 mA/A + 0.16 µA 1.6 mA/A + 0.15 µA 0.8 mA/A + 0.15 µA 1.6 mA/A + 0.2 µA 4 mA/A + 0.25 µA 1.4 mA/A + 2 µA 0.32 mA/A + 1.8 µA 0.65 mA/A + 1.8 µA 1.6 mA/A + 2.5 µA 1.5 mA/A + 18 µA 0.32 mA/A + 18 µA 0.8 mA/A + 40 µA 1.6 mA/A + 80 µA 1.4 mA/A + 0.15 mA 0.4 mA/A + 0.15 mA 5 mA/A + 0.8 mA 1.5 mA/A + 0.15 mA 0.5 mA/A + 0.15 mA 0.5 mA/A + 0.15 mA 4.8 mA/A + 6 mA 0.5 mA/A + 1.8 mA 0.8 mA/A + 2 mA 0.95 mA/A + 7 mA 1.2 mA/A + 8.2 mA	Fluke 5502A Multiproduct Calibrator

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment	
Resistance ¹ Source	(0 to 11) Ω (11 to 33) Ω (33 to 110) Ω (110 to 330) Ω 330 Ω to 1.1 kΩ (1.1 to 3.3) kΩ (3.3 to 11) kΩ (11 to 33) kΩ (33 to 110) kΩ (110 to 330) kΩ 330 kΩ to 1.1 MΩ (1.1 to 3.3) MΩ (3.3 to 11) MΩ (11 to 33) MΩ	0.1 mΩ/Ω + 10 mΩ 0.1 mΩ/Ω + 15 mΩ 0.08 mΩ/Ω + 15 mΩ 0.08 mΩ/Ω + 20 mΩ 0.08 mΩ/Ω + 0.1 Ω 0.08 mΩ/Ω + 0.2 Ω 0.08 mΩ/Ω + 0.8 Ω 0.08 mΩ/Ω + 1.2 Ω 0.1 mΩ/Ω + 6 Ω 0.11 mΩ/Ω + 12 Ω 0.13 mΩ/Ω + 0.07 kΩ 0.13 mΩ/Ω + 0.15 kΩ 0.48 mΩ/Ω + 1 kΩ 0.8 mΩ/Ω + 3 kΩ	Fluke 5502A Multiproduct Calibrator	
Capacitance ¹ Source	10 Hz to 10 kHz 10 Hz to 10 kHz 10 Hz to 3 kHz 10 Hz to 1 kHz 10 Hz to 1 kHz 10 Hz to 1 kHz 10 Hz to 1 kHz 10 Hz to 600 Hz 10 Hz to 300 Hz 10 Hz to 150 Hz 10 Hz to 120 Hz 10 Hz to 80 Hz 50 Hz 20 Hz 6 Hz 2 Hz 0.6 Hz 0.2 Hz	(0.1 to 0.5) nF (0.5 to 1.09) nF (1.1 to 3.29) nF (3.3 to 10.9) nF (11 to 32.9) nF (33 to 109.9) nF (110 to 329.9) nF (0.33 to 1.09) μF (1.1 to 3.29) μF (3.3 to 10.9) μF (11 to 32.9) μF (33 to 109.9) μF (110 to 329.9) μF (0.33 to 1.09) mF (1.1 to 3.29) mF (3.3 to 10.9) mF (11 to 32.9) mF (33 to 50) mF	0.4 % of reading + 8.0 pF 0.4 % of reading + 10 pF 0.4 % of reading + 10 pF 0.2 % of reading + 12 pF 0.2 % of reading + 0.1 nF 0.2 % of reading + 0.1 nF 0.2 % of reading + 0.7 nF 0.2 % of reading + 1.3 nF 0.2 % of reading + 7 nF 0.2 % of reading + 10 nF 0.32 % of reading + 0.08 μF 0.37 % of reading + 0.11 μF 0.37 % of reading + 0.7 μF 0.37 % of reading + 1 μF 0.37 % of reading + 6.5 μF 0.37 % of reading + 10 μF 0.6 % of reading + 63 μF 0.85 % of reading + 98 μF	Fluke 5502A Multiproduct Calibrator
DC Current Clamp ¹ Source	Up to 200 A (> 200 to 550) A (> 550 to 1 000) A	3.8 mA/A + 0.06 A 3.3 mA/A + 0.08 A 3.2 mA/A + 0.07 A	Fluke 5502A Multiproduct Calibrator with Current Coil	

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Current Clamp ¹ Source	Up to 20 A (45 to 100) Hz (> 100 to 440) Hz (> 20 to 200) A (45 to 65) Hz (> 65 to 100) Hz (> 100 to 440) Hz (> 200 to 550) A (45 to 65) Hz (> 65 to 100) Hz (> 550 to 1 000) A (45 to 65) Hz (> 65 to 100) Hz	5 mA/A + 0.08 A 12 mA/A + 0.08 A 5 mA/A + 0.08 A 9.5 mA/A + 0.08 A 14 mA/A + 0.08 A 3.7 mA/A + 0.072 A 9 mA/A + 0.06 A 3.7 mA/A + 0.08 A 9.3 mA/A + 0.08 A	Fluke 5502A Multiproduct Calibrator with Current Coil
Insulation Resistance ¹ Source Test Voltage @ 50 V, 100 V, 250 V, 500 V, 1 000 V	(0.1 to 10) MΩ (10 to 20) MΩ (20 to 30) MΩ (30 to 50) MΩ (50 to 100) MΩ (100 to 200) MΩ (200 to 500) MΩ (500 to 1 000) MΩ	0.005 8 MΩ 0.032 MΩ 0.069 MΩ 0.075 MΩ 0.094 MΩ 2.8 MΩ 4.5 MΩ 7.1 MΩ	Resistance Decade Box
Temperature Indicator of Thermocouple (Electrical Simulation) Source	Type K (-200 to -100) °C (-100 to -25) °C (-25 to 120) °C (120 to 1 000) °C (1 000 to 1 372) °C Type B (600 to 800) °C (800 to 1 000) °C (1 000 to 1 550) °C (1 550 to 1 820) °C Type E (-250 to -100) °C (-100 to -25) °C (-25 to 350) °C (350 to 650) °C (650 to 1 000) °C	0.46 °C 0.26 °C 0.23 °C 0.37 °C 0.56 °C 0.61 °C 0.48 °C 0.42 °C 0.46 °C 0.7 °C 0.23 °C 0.2 °C 0.23 °C 0.3 °C	Fluke 5502A Multiproduct Calibrator

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Temperature Indicator of Thermocouple (Electrical Simulation) Source	Type J (-210 to -100) °C (-100 to -25) °C (-25 to 150) °C (150 to 760) °C (760 to 1 200) °C Type N (-250 to -100) °C (-100 to -25) °C (-25 to 120) °C (120 to 410) °C (410 to 1 300) °C Type R (0 to 250) °C (250 to 400) °C (400 to 1 000) °C (1 000 to 1 767) °C Type S (0 to 250) °C (250 to 400) °C (400 to 1 000) °C (1 000 to 1 767) °C Type U (-200 to 0) °C (0 to 600) °C Type T (-250 to -150) °C (-150 to 0) °C (0 to 120) °C (120 to 400) °C	0.56 °C 0.32 °C 0.28 °C 0.24 °C 0.33 °C 0.56 °C 0.32 °C 0.28 °C 0.26 °C 0.38 °C 0.8 °C 0.5 °C 0.47 °C 0.56 °C 0.66 °C 0.51 °C 0.52 °C 0.65 °C 0.79 °C 0.38 °C 0.88 °C 0.34 °C 0.23 °C 0.21 °C	Fluke 5502A Multiproduct Calibrator

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Temperature Indicator Simulation of Resistance Temperature Detector (RTD) Source	<p>100 Ω, Pt385 (-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 300) °C (300 to 400) °C (400 to 630) °C (630 to 800) °C</p> <p>200 Ω, Pt385 (-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 260) °C (260 to 300) °C (300 to 400) °C (400 to 600) °C (600 to 630) °C</p> <p>500 Ω, Pt385 (-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 260) °C (260 to 300) °C (300 to 400) °C (400 to 600) °C (600 to 630) °C</p> <p>1 000 Ω, Pt385 (-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 260) °C (260 to 300) °C (300 to 400) °C (400 to 600) °C (600 to 630) °C</p>	<p>0.09 °C 0.09 °C 0.14 °C 0.14 °C 0.15 °C 0.18 °C 0.33 °C</p> <p>0.08 °C 0.08 °C 0.08 °C 0.09 °C 0.18 °C 0.19 °C 0.2 °C 0.23 °C</p> <p>0.08 °C 0.09 °C 0.09 °C 0.1 °C 0.13 °C 0.13 °C 0.14 °C 0.16 °C</p> <p>0.08 °C 0.09 °C 0.09 °C 0.1 °C 0.13 °C 0.13 °C 0.14 °C 0.16 °C</p>	Fluke 5502A Multiproduct Calibrator

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Temperature Indicator Simulation of Resistance Temperature Detector (RTD) Source	100 Ω, Pt3916 (-200 to -190) °C (-190 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 260) °C (260 to 300) °C (300 to 400) °C (400 to 600) °C (600 to 630) °C 100 Ω, Pt3926 (-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 300) °C (300 to 400) °C (400 to 630) °C	0.36 °C 0.08 °C 0.09 °C 0.11 °C 0.11 °C 0.13 °C 0.14 °C 0.15 °C 0.33 °C 0.08 °C 0.09 °C 0.12 °C 0.14 °C 0.16 °C 0.18 °C	Fluke 5502A Multiproduct Calibrator
DC Power ¹ Source	(0.33 to 1 000) V, < 0.33 A (0.108 9 to < 330) W (0.33 to 1 000) V, (0.33 to < 3) A (330 to < 3.0) kW (0.33 to 1 000) V, (3 to < 10.9) A (3.0 to < 10.9) kW (0.33 to 1 000) V, (10.99 to 20) A (10.9 to 20) kW	0.10 mW/W + 6 mW 0.31 mW/W + 60 mW 0.5 mW/W + 0.6 W 0.81 mW/W + 0.6 W	Fluke 5502A Multiproduct Calibrator
AC Power ¹ Source	(45 to 65) Hz, PF=1 (0.33 to 1 000) V up to 0.329 A (0.109 to < 10.9) W (10.9 to < 330) W	0.55 mW/W + 1.5 mW 0.8 mW/W + 6 mW	Fluke 5502A Multiproduct Calibrator

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Power ¹ Source	(0.33 to 1 000) V, (0.33 to < 3) A 330 W to < 3 kW (0.33 to 1 000) V, (3 to < 10.9) A (3 to < 3.5) kW (3.5 to < 10.9) kW (0.33 to 1 000) V, (10.9 to 20) A (10.9 to 20) kW	1.2 mW/W + 0.06 W 1.4 mW/W + 0.06 W 1.4 mW/W + 0.6 W 1.2 mW/W + 0.6 W	Fluke 5502A Multiproduct Calibrator
DC Voltage ¹ Measure	Up to 100 mV (> 0.1 to 1) V (> 1 to 10) V (> 10 to 100) V (>100 to 1 000) V	14 µV/V + 0.35 µV 4.9 µV/V + 0.35 µV 4.7 µV/V + 0.58 µV 7 µV/V + 0.035 mV 21 µV/V + 0.12 mV	Digital Multimeter HP 3458A
AC Voltage ¹ Measure	100 mV to 10 V (10 to 50) Hz > 50 Hz to 1 kHz > 300 kHz to 1 MHz	85 µV/V + 0.46 mV 85 µV/V+0.23 mV 0.16 mV/V+0.23 mV 0.35 mV/V +0.23 mV 0.93 mV/V+0.23 mV 3.5 mV/V+1.2 mV 12 mV/V+1.2 mV	Digital Multimeter HP 3458A
AC Voltage ¹ Measure	(> 10 to 100) V (10 to 50) Hz > 50 Hz to 1kHz (10 to 50) Hz > 50 Hz to 1 kHz <td>0.23 mV/V+4.6 mV 0.23 mV/V+2.3 mV 0.23 mV/V+2.3 mV 0.41 mV/V+2.3 mV 1.4 mV/V+2. 3 mV 0.46 mV/V+ 0.046 V 0.46 mV/V + 0.023 V 0.69 mV/V+ 0.023 V 1.4 mV/V+ 0.023 V 3.5 mV/V+ 0.023 V</br></td> <td>Digital Multimeter HP 3458A</td>	0.23 mV/V+4.6 mV 0.23 mV/V+2.3 mV 0.23 mV/V+2.3 mV 0.41 mV/V+2.3 mV 1.4 mV/V+2. 3 mV 	Digital Multimeter HP 3458A
DC Current ¹ Measure	(> 10 to 100) µA <td>24 µA/A + 0.92 nA 24 µA/A + 5.8 nA 24 µA/A + 58 nA 41 µA/A + 0.58 µA 0.13 mA/A + 0.012 mA</td> <td>Digital Multimeter HP 3458A</td>	24 µA/A + 0.92 nA 24 µA/A + 5.8 nA 24 µA/A + 58 nA 41 µA/A + 0.58 µA 0.13 mA/A + 0.012 mA	Digital Multimeter HP 3458A

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
DC Current ¹ Measure	(>1 to 3) A	2.4 mA/A + 1.1 mA	Digital Multimeter 34460A
AC Current ¹ Measure	(0.1 to 1) mA (10 to 20) Hz (>20 to 45) Hz (>45 to 100) Hz >100 Hz to 1 kHz (1 to 100) mA (10 to 20) Hz (>20 to 45) Hz (>45 to 100) Hz >100 Hz to 1 kHz (0.1 to 1) A (10 to 20) Hz (>20 to 45) Hz (>45 to 100) Hz >100 Hz to 1 kHz	4.6 mA/A + 0.35 µA 1.7 mA/A + 0.35 µA 0.7 mA/A + 0.35 µA 0.7 mA/A + 0.35 µA 4.6 mA/A + 0.23 mA 1.7 mA/A + 0.023 mA 0.7 mA/A + 0.023 mA 0.35 mA/A + 0.023 mA 4.6 mA/A + 0.23 mA 1.8 mA/A + 0.23 mA 0.93 mA/A + 0.23 mA 1.2 mA/A + 0.23 mA	Digital Multimeter HP 3458A
AC Current ¹ Measure	(>1 to 3) A 50 Hz to 5 kHz	2.7 mA/A + 2mA	Digital Multimeter 34460A
Resistance Measure ¹	Up to 10 Ω (> 10 to 100) Ω > 100 Ω to 1 kΩ (> 1 to 10) kΩ (> 10 to 100) kΩ (> 0.1 to 1) MΩ (> 1 to 10) MΩ (> 10 to 100) MΩ > 100 MΩ to 1 GΩ	18 µΩ/Ω + 0.058 mΩ 14 µΩ/Ω + 0.58 mΩ 12 µΩ/Ω + 0.58 mΩ 1 µΩ/Ω + 5.8 mΩ 12 µΩ/Ω + 58 mΩ 19 µΩ/Ω + 2.3 Ω 59 µΩ/Ω + 0.12 kΩ 0.58 mΩ/Ω + 1.2 kΩ 5.8 mΩ/Ω + 0.012 MΩ	Digital Multimeter HP 3458A
DC High Voltage ¹ Measure	Up to 1 kV (> 1 to 3) kV (> 3 to 5) kV (> 5 to 10) kV	24 mV/V + 0.06 mV 24 mV/V + 0.07 mV 24 mV/V + 0.09 mV 24 mV/V + 0.18 mV	Digital Multimeter 34460A with Fluke 80K-40 High voltage probe
AC High Voltage ¹ Measure	(1 to 6) kV (50 to 60) Hz	58 mV/V + 4 mV	Digital Multimeter 34460A with Fluke 80K-40 High voltage probe
LCR Meter Inductance (L)	1 µH to 10 H @ 100 mV, 1 V, 1 kHz	1.2 % of reading + 0.9 µH	Decade Inductance iET1492
LCR Meter Capacitance (C)	1 pF to 1 µF @ 1 V, 1 kHz	0.06 % of reading +0.6 pF	Precision Decade Capacitor, GR1413

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
LCR Meter Resistance (R)	1 Ω to 100 kΩ @ 1V, 1 kHz	0.2 % of reading +2.4 mΩ	Decade Resistance Box
Inductance Source	1 µH to 10 H @ 1 V, 1 kHz	0.06 % of reading	LCR Meter Agilent E4980A
Capacitance Source	1pF to 1µF @ 1 V, 0.1 kHz to 1 MHz	0.06 % of reading	LCR Meter, Agilent E4980A
Oscilloscope ¹ Vertical deflection DC 50 Ω and 1 MΩ	2 mV 5 mV 10 mV 20 mV 50 mV 100 mV 200 mV 500 mV 1 V 2 V 5 V 10 V 20 V	0.84 % of reading 0.49 % of reading 0.34 % of reading 0.26 % of reading 0.29 % of reading 0.23 % of reading 0.21 % of reading 0.28 % of reading 0.27 % of reading 0.22 % of reading 0.28 % of reading 0.2 % of reading 0.2 % of reading	Multi Product Calibrator Model: 5502A, Universal frequency Counter Calibrator model: PM6685R, Digital Multimeter model: 3458A
Oscilloscope Vertical Bandwidth ¹ 3 dB down from reference amplitude	50 kHz to 100 MHz (>100 to 300) MHz	1.4 % of reading 1.8 % of reading	Multi Product Calibrator Model: 5502A, Universal frequency Counter Calibrator model: PM6685R, Digital Multimeter model: 3458A
Oscilloscope Horizontal deflection: Time Mark ¹	1 ns 2 ns 5 ns 10 ns 20 ns 50 ns 100 ns 200 ns 500 ns 1 µs 2 µs 5 µs	0.01 % of reading 0.04 % of reading 0.01 % of reading 0.01 % of reading 0.04 % of reading 0.01 % of reading 0.01 % of reading 0.04 % of reading 0.01 % of reading 0.01 % of reading 0.04 % of reading 0.01 % of reading	Multi Product Calibrator Model: 5502A

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Oscilloscope Horizontal deflection: Time Mark ¹	10 µs 20 µs 50 µs 100 µs 200 µs 500 µs 1 ms 2 ms 5 ms 10 ms 20 ms 50 ms 100 ms 200 ms 500 ms 1 s 2 s 5 s 10 s	0.01 % of reading 0.04 % of reading 0.01 % of reading 0.01 % of reading 0.04 % of reading 0.01 % of reading 0.01 % of reading 0.04 % of reading 0.01 % of reading 0.01 % of reading 0.04 % of reading 0.01 % of reading 0.01 % of reading 0.04 % of reading 0.01 % of reading 0.62 % of reading 1.2 % of reading 3.1 % of reading 6.2 % of reading	Multi Product Calibrator Model: 5502A
Oscilloscope DC accuracy ¹ 50 Ω and 1 MΩ (Digital)	2 mV 5 mV 10 mV 20 mV 50 mV 100 mV 200 mV 500 mV 1 V 2 V 5 V 10 V 20 V	0.11 % of reading 0.39 % of reading 0.19 % of reading 0.1 % of reading 0.38 % of reading 0.19 % of reading 0.1 % of reading 0.38 % of reading 0.19 % of reading 0.1 % of reading 0.04 % of reading 0.02 % of reading 0.01 % of reading	Multi Product Calibrator Model: 5502A, Universal frequency Counter Calibrator Model: PM6685R, Digital Multimeter Model: 3458A
Oscilloscope Time base ^{1,3}	10 MHz	$2.4 \times 10^{-10} f$	Multi Product Calibrator Model: 5502A, Universal frequency Counter Calibrator Model: PM6685R, Digital Multimeter Model: 3458A

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Oscilloscope Calibrator calibration ¹	$\leq 10 \text{ Vp-p} @ \leq 10 \text{ kHz}$	0.02 % of reading	Multi Product Calibrator Model: 5502A, Universal frequency Counter Calibrator Model: PM6685R, Digital Multimeter Model: 3458A
Rise Time, Fall Time, Phase Source	Rise/Fall Time 10 ns to 10 ms Phase 0° to 360°	2 ns 1.2 °	Universal Counter Agilent 53131A, Universal Frequency Counter Calibrator Fluke PM6685R
Single and Three Phase Power Meter	AC Voltage @ 50/60 Hz (0 to 600) V AC Current @ 50/60 Hz (0 to 1 000) A AC Power @ 50/60 Hz (0 to 60) kW Power Factor (0.5 to 1)	0.58 % of reading 1.3 % of reading 1.3 % of reading 1.2 % of reading	Power Meter, Hioki 3197 And Clamp Sensor, Hioki 9669. (Compare With Power Meter Standard)

Electrical – RF/Microwave

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
⁴ Tuned RF Level Measure 10 dB/step	(-40 to 0) dB 10 MHz 50 MHz 100 MHz 400 MHz 1 000 MHz 2 000 MHz 3 000 MHz 4 000 MHz 5 000 MHz 6 000 MHz 7 000 MHz 8 000 MHz 9 000 MHz	0.11 dB 0.10 dB 0.10 dB 0.10 dB 0.10 dB 0.11 dB 0.11 dB 0.13 dB 0.11 dB 0.13 dB 0.17 dB 0.15 dB 0.12 dB	HP 8902A Measuring Receiver and HP 11722A/11792A Power Sensor

Electrical – RF/Microwave

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
⁴ Tuned RF Level Measure 10 dB/step	(-40 to 0) dB 1 0000 MHz 11 000 MHz 12 000 MHz 13 000 MHz 14 000 MHz 15 000 MHz 16 000 MHz 17 000 MHz 18 000 MHz	0.12 dB 0.11 dB 0.16 dB 0.15 dB 0.14 dB 0.23 dB 0.26 dB 0.17 dB 0.21 dB	HP 8902A Measuring Receiver and HP 11722A/11792A Power Sensor
Distortion Source	@ 20 Hz to 20 kHz (-80 to -40) dB @ (>20 to 100) kHz (-80 to -40) dB	1.2 dB 2.3 dB	Audio Analyzer, HP 8903B

Length – Dimensional Metrology

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
¹ External Micrometer V-Anvil, Screw Thread, Indicating	Up to 100 mm (100 to 125) mm (125 to 150) mm (150 to 175) mm (175 to 200) mm (200 to 250) mm (250 to 300) mm (300 to 400) mm (400 to 500) mm (500 to 600) mm (600 to 1 000) mm	1.5 µm 1.8 µm 2.1 µm 2.4 µm 2.8 µm 3.4 µm 4.1 µm 5.4 µm 6.8 µm 8.1 µm 13.5 µm	Gauge Block Set
¹ Vernier Caliper Dial and Digital	Up to 200 mm (200 to 300) mm (300 to 400) mm (400 to 500) mm (500 to 600) mm (600 to 700) mm (700 to 800) mm (800 to 900) mm (900 to 1 000) mm (1 000 to 1 500) mm	0.006 mm 0.007 mm 0.008 mm 0.009 mm 0.010 mm 0.011 mm 0.012 mm 0.013 mm 0.015 mm 0.021 mm	Gauge Block Set

Length – Dimensional Metrology

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
¹ Can Seam Micrometer	Up to 13 mm	2.3 µm	Gauge Block Set
¹ Internal Micrometer All type Snap Micrometer (Up to 100 mm)	Up to 30 mm (30 to 45) mm (45 to 50) mm (50 to 60) mm (60 to 70) mm (70 to 80) mm (80 to 87) mm (87 to 97) mm (97 to 100) mm (100 to 125) mm (125 to 150) mm (150 to 175) mm	0.7 µm 0.8 µm 0.9 µm 1 µm 1.1 µm 1.2 µm 1.3 µm 1.4 µm 1.5 µm 1.8 µm 2.1 µm 2.4 µm	Gauge Block Set
¹ Internal Micrometer All type Snap Micrometer (Up to 100 mm)	(175 to 200) mm (200 to 250) mm (250 to 300) mm (300 to 400) mm (400 to 500) mm (500 to 600) mm	2.8 µm 3.4 µm 4.1 µm 5.4 µm 6.8 µm 8.1 µm	Gauge Block Set
¹ Caliper Gauge External	Up to 25 mm (25 to 50) mm	1.2 µm 1.3 µm	Gauge Block
¹ Caliper Gauge Internal (0.005mm) Internal (0.01mm)	2.5 to 15 mm (10 to 180) mm	3 µm 6 µm	Gauge Block
¹ Thickness Gauge	Up to 20 mm (20 to 25) mm	0.6 µm 0.7 µm	Gauge Block
¹ Height Gauge Dial and Digital	Up to 20 mm (20 to 50) mm (50 to 100) mm (100 to 150) mm (150 to 200) mm (200 to 250) mm (250 to 300) mm (300 to 400) mm (400 to 500) mm (500 to 600) mm (600 to 700) mm (700 to 800) mm (800 to 900) mm (900 to 1 000) mm	0.6 µm 0.9 µm 1.5 µm 2.1 µm 2.8 µm 3.4 µm 4.1 µm 5.4 µm 6.8 µm 8.1 µm 9.5 µm 11 µm 12 µm 14 µm	Gauge Block Set

Length – Dimensional Metrology

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Feeler Gauge / Thickness Plate	Up to 1 mm (1 to 5) mm	0.21 µm 0.22 µm	ULM
Measuring Foil Standard Foil	Up to 1 mm (1 to 5) mm	0.21 µm 0.22 µm	ULM
¹ Indicator	Up to 20 mm (20 to 30) mm (30 to 40) mm (40 to 50) mm (50 to 60) mm (60 to 70) mm (70 to 80) mm (80 to 90) mm (90 to 100) mm	0.6 µm 0.7 µm 0.8 µm 0.9 µm 1 µm 1.1 µm 1.2 µm 1.3 µm 1.5 µm	Gauge Block
	Up to 5 mm (5 to 12) mm (12 to 20) mm (20 to 25) mm (25 to 50) mm	0.1 µm 0.2 µm 0.3 µm 0.4 µm 0.7 µm	
	Up to 100 mm (100 to 200) mm (200 to 300) mm (300 to 400) mm (400 to 500) mm (500 to 600) mm (600 to 700) mm (700 to 800) mm (800 to 900) mm (900 to 1 200) mm (1 200 to 1 500) mm (1 500 to 1 800) mm (1 800 to 2 000) mm	3 µm 4 µm 5 µm 6 µm 7 µm 9 µm 10 µm 11 µm 12 µm 16 µm 20 µm 24 µm 27 µm	
	Up to 200 mm (200 to 400) mm (400 to 600) mm (600 to 800) mm (800 to 1 000) mm (1 000 to 1 200) mm (1 200 to 1 400) mm	0.004 mm 0.012 mm 0.017 mm 0.03 mm 0.05 mm 0.06 mm 0.09 mm	

Length – Dimensional Metrology

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Steel Tape & Textile Tape	(1 400 to 1 600) mm (1 600 to 1 800) mm (1 800 to 2 000) mm (2 000 to 3 000) mm (3 000 to 4 000) mm (4 000 to 5 000) mm (5 000 to 6 000) mm (6 000 to 7 000) mm (7 000 to 8 000) mm (8 000 to 9 000) mm (9 000 to 10 000) mm (10 000 to 20 000) mm (20 000 to 30 000) mm (30 000 to 40 000) mm (40 000 to 50 000) mm	0.13 mm 0.14 mm 0.19 mm 0.4 mm 0.74 mm 1.1 mm 1.6 mm 2.2 mm 2.9 mm 3.6 mm 4.5 mm 18 mm 40 mm 71 mm 0.11 m	3D Vision Measuring Machine
¹ Depth Micro Checker, Step Gauge, Inside Checker, Anvil Block	Up to 100 mm (100 to 200) mm (200 to 250) mm (250 to 300) mm Up to 25 mm	2 µm 3 µm 4 µm 5 µm 2 µm	Gauge Block/ Linear Height Master
¹ Depth Gauge, Depth Micrometer	Up to 25 mm (25 to 50) mm (50 to 100) mm (100 to 150) mm (150 to 250) mm (250 to 300) mm (300 to 400) mm (400 to 450) mm	0.7 µm 0.9 µm 1 µm 2 µm 3 µm 4 µm 5 µm 6 µm	Gauge Block Set
¹ Surface Plate Overall Flatness Local Area Flatness (Repeat Reading)	Up to 4 m Diagonal (>4 to 10) m Up to 0.1 µm	1.5 µm 6.5 µm 1 µm	Planekator (Straight Edge) and Dial Indicator

Length – Dimensional Metrology

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Plain Plug Gauge, Pin Gauge, Three Wires, T-probe	Up to 15 mm (15 to 22) mm (22 to 30) mm (30 to 40) mm (40 to 50) mm (50 to 60) mm (60 to 70) mm (70 to 80) mm (80 to 90) mm (90 to 100) mm (100 to 150) mm (150 to 200) mm (200 to 250) mm (250 to 300) mm	0.3 µm 0.4 µm 0.5 µm 0.6 µm 0.7 µm 0.9 µm 1 µm 1.2 µm 1.3 µm 1.4 µm 2 µm 2.7 µm 3.4 µm 4 µm	ULM / Gauge Block
Plain Ring Gauge	Up to 3 mm (3 to 6) mm (6 to 10) mm (10 to 12) mm (12 to 16) mm (16 to 18) mm (18 to 20) mm (20 to 22) mm (22 to 25) mm (25 to 28) mm (28 to 30) mm (30 to 75) mm (75 to 100) mm (100 to 300) mm	0.44 µm 0.45 µm 0.46 µm 0.48 µm 0.5 µm 0.51 µm 0.53 µm 0.57 µm 0.59 µm 0.61 µm 0.63 µm 2.3 µm 3.1 µm 4.9 µm	ULM / Plain Ring Gauge
¹ Check Master /Caliper Checker	Up to 100 mm (100 to 125) mm (125 to 150) mm (150 to 175) mm (175 to 200) mm (200 to 250) mm (250 to 300) mm (300 to 400) mm (400 to 500) mm (500 to 600) mm (600 to 700) mm	2.7 µm 2.9 µm 3.1 µm 3.3 µm 3.6 µm 4.1 µm 4.7 µm 5.9 µm 7.1 µm 8.4 µm 9.7 µm	Linear Height Master / Gauge Block

Length – Dimensional Metrology

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Thread Plug Gauge	(M2 to M10) mm	0.47 µm	
	(M10 to M20) mm	0.49 µm	
	(M20 to M50) mm	0.51 µm	
	(M50 to M70) mm	0.55 µm	
	(M70 to M100) mm	0.61 µm	
	(M100 to M150) mm	0.63 µm	
Pitch Diameter	(M2 to M10) mm	0.3 µm	
	(M10 to M20) mm	0.4 µm	
	(M20 to M30) mm	0.5 µm	
	(M30 to M40) mm	0.6 µm	
	(M40 to M50) mm	0.7 µm	
	(M50 to M60) mm	0.9 µm	
	(M60 to M70) mm	1 µm	
	(M70 to M80) mm	1.2 µm	
	(M80 to M90) mm	1.3 µm	
	(M90 to M100) mm	1.4 µm	
	(M100 to M125) mm	1.7 µm	
	(M125 to M150) mm	2 µm	
Major Diameter	(M2 to M5) mm	0.57 µm	
	(M5 to M8) mm	0.58 µm	
	(M8 to M10) mm	0.59 µm	
	(M10 to M12) mm	0.6 µm	
	(M12 to M18) mm	0.63 µm	
	(M18 to M20) mm	0.64 µm	
	(M20 to M25) mm	0.68 µm	
	(M25 to M30) mm	0.72 µm	
	(M30 to M75) mm	2.3 µm	
	(M75 to M90) mm	2.4 µm	
	(M90 to M100) mm	2.5 µm	
	(M100 to M125) mm	2.7 µm	
	(M125 to M150) mm	2.9 µm	
Thread Ring Gauge	(M2 to M8) mm	0.4 µm	
	(M8 to M20) mm	0.5 µm	
	(M20 to M30) mm	0.6 µm	
	(M30 to M75) mm	1.1 µm	
	(M75 to M90) mm	1.3 µm	
	(M90 to M100) mm	1.4 µm	
	(M100 to M125) mm	1.8 µm	
	(M125 to M150) mm	2.1 µm	
Pitch Diameter	(M2 to M8) mm	0.4 µm	ULM / Plain Ring Gauge
	(M8 to M20) mm	0.5 µm	
	(M20 to M30) mm	0.6 µm	
	(M30 to M75) mm	1.1 µm	
	(M75 to M90) mm	1.3 µm	
	(M90 to M100) mm	1.4 µm	
	(M100 to M125) mm	1.8 µm	
	(M125 to M150) mm	2.1 µm	
Minor Diameter	(M2 to M8) mm	0.4 µm	
	(M8 to M20) mm	0.5 µm	
	(M20 to M30) mm	0.6 µm	
	(M30 to M75) mm	1.1 µm	
	(M75 to M90) mm	1.3 µm	
	(M90 to M100) mm	1.4 µm	
	(M100 to M125) mm	1.8 µm	
	(M125 to M150) mm	2.1 µm	

Length – Dimensional Metrology

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
¹ Dial Gauge Tester, Calibration Tester	Up to 5 mm (5 to 12) mm (12 to 20) mm (20 to 25) mm (25 to 50) mm	0.65 µm 0.66 µm 0.68 µm 0.7 µm 0.73 µm	Liner Gauge with Display
Plain Snap Gauge/Gap Gauge (External)	(2 to 4) mm (4 to 16) mm (16 to 22) mm (22 to 30) mm (30 to 75) mm (75 to 100) mm (100 to 200) mm (200 to 300) mm (300 to 400) mm (400 to 500) mm	0.2 µm 0.3 µm 0.4 µm 0.5 µm 1.1 µm 1.4 µm 2.7 µm 4 µm 5.4 µm 6.7 µm	ULM / Gauge Block
Plain Snap Gauge / Gap Gauge (Internal)	(2 to 6) mm (6 to 20) mm (20 to 30) mm (30 to 75) mm (75 to 100) mm (100 to 300) mm	0.4 µm 0.5 µm 0.6 µm 2.3 µm 2.4 µm 4.5 µm	ULM / Plain Ring Gauge
¹ Hole test, Three-Point Micrometer	(2 to 3) mm (3 to 8) mm (8 to 18) mm (18 to 20) mm (20 to 25) mm (25 to 28) mm (28 to 30) mm 75 mm	0.8 µm 0.9 µm 1.2 µm 1.3 µm 1.4 µm 1.5 µm 1.7 µm 3 µm	Master Ring Gauge
Dial Test Indicator	Up to 1.6 mm	0.3 µm	ULM
¹ Universal Length Measuring Machine	Up to 1 mm (1 to 3) mm (3 to 5) mm (5 to 10) mm (10 to 25) mm (25 to 50) mm (50 to 75) mm (75 to 100) mm (100 to 125) mm	0.06 µm 0.07 µm 0.09 µm 0.15 µm 0.34 µm 0.67 µm 1 µm 1.3 µm 1.7 µm	Gauge Block

Length – Dimensional Metrology

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
¹ Universal Length Measuring Machine	(125 to 150) mm (150 to 175) mm (175 to 200) mm (200 to 250) mm (250 to 300) mm (300 to 400) mm (400 to 500) mm	2.1 µm 2.4 µm 2.7 µm 3.4 µm 4.1 µm 5.4 µm 6.7 µm	Gauge Block
¹ Vernier Depth Gauge	Up to 200 mm (200 to 300) mm (300 to 400) mm (400 to 500) mm (500 to 600) mm (600 to 700) mm (700 to 800) mm (800 to 900) mm (900 to 1 000) mm	6 µm 7 µm 8 µm 9 µm 10 µm 11 µm 12 µm 13 µm 15 µm	Gauge Block Set
Bore Gauge / Cylinder Gauge	(0.5 to 10) mm (10 to 30) mm (30 to 50) mm (50 to 70) mm (70 to 100) mm (100 to 125) mm (125 to 150) mm (150 to 175) mm (175 to 200) mm (200 to 250) mm (250 to 300) mm (300 to 400) mm	0.6 µm 0.8 µm 0.9 µm 1.1 µm 1.5 µm 1.8 µm 2.1 µm 2.5 µm 2.8 µm 3.5 µm 4.1 µm 5.4 µm	ULM / Gauge Block
Bore Gauge / Cylinder Gauge	(400 to 500) mm (500 to 600) mm (600 to 700) mm (700 to 800) mm	6.8 µm 8.1 µm 9.5 µm 11 µm	ULM / Gauge Block
¹ Profile Projector	Up to 50 mm (50 to 200) mm (200 to 410) mm	2 µm 3 µm 7 µm	Glass Scale
Linearity	(0.25 to 30) °	12 second	Angle Block Set
¹ Measuring Microscope, Optical Comparator, 3D Vision Measuring System	Up to 50 mm (50 to 200) mm (200 to 410) mm	2 µm 3 µm 7 µm	Glass Scale

Length – Dimensional Metrology

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
¹ Height Master	Up to 175 mm (175 to 250) mm (250 to 300) mm (300 to 400) mm (400 to 500) mm (500 to 600) mm (600 to 700) mm	3 µm 4 µm 5 µm 6 µm 7 µm 8 µm 10 µm	Gauge Block / Linear Height Master
Bevel Protractor	Up to 30 ° (30 to 45) ° (45 to 90) ° Up to 100 mm (100 to 200) mm (200 to 300) mm	12 second 24 second 48 second 3 µm 4 µm 5 µm	Angle Block 3D Vision Measuring Machine
Chamfer Gauge	Up to 10 mm	3 µm	3D Vision Measuring Machine
Pitch Gauge	Up to 7 mm	3 µm	3D Vision Measuring Machine
Radius Gauge	Up to 100 mm	3 µm	3D Vision Measuring Machine
Taper Gauge (Scale Type)	Up to 100 mm	3 µm	3D Vision Measuring Machine
Taper Thread Ring	M2 to M5 M5 to M11 M11 to M22 M22 to M45 M45 to M180	0.9 µm 0.91 µm 1.8 µm 5.1 µm 11 µm	ULM / Ring Gauge
¹ Riser Block	150 mm 300 mm 600 mm	9 µm 10 µm 12 µm	Linear Height Master / Gauge Block
Long Gauge Block (Grade 1, 2)	100 mm (100 to 125) mm (125 to 150) mm (150 to 175) mm (175 to 200) mm (200 to 250) mm (250 to 300) mm (300 to 400) mm (400 to 500) mm	1.3 µm 1.7 µm 2.1 µm 2.4 µm 2.7 µm 3.4 µm 4.1 µm 5.4 µm 6.7 µm	ULM / Gauge Block

Length – Dimensional Metrology

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Standard Micrometer, Setting Rod, Length Bar	Up to 25 mm (25 to 50) mm (50 to 75) mm (75 to 100) mm (100 to 125) mm (125 to 150) mm (150 to 175) mm (175 to 200) mm (200 to 300) mm (300 to 400) mm (400 to 500) mm	0.4 µm 0.7 µm 1.1 µm 1.4 µm 1.7 µm 2 µm 2.4 µm 2.7 µm 4 µm 5.4 µm 6.7 µm	ULM / Gauge Block
Angle Block / Angular	(0.25 to 30) ° (30 to 45) ° (45 to 60) ° (60 to 90) °	12 second 24 second 36 second 48 second	Angle Block / 3D Vision
Gauge Block	1 mm (1 to 5) mm (5 to 10) mm (10 to 25) mm (25 to 50) mm (50 to 75) mm (75 to 100) mm	0.22 µm 0.23 µm 0.26 µm 0.43 µm 0.72 µm 1.1 µm 1.4 µm	ULM / Gauge Block
Test Sieve	Up to 50 mm	3 µm	3D Vision Measuring Machine
Taper Plug Gauge	Up to M7 M7 to M15 M15 to M25 M25 to M30 M30 to M40 M40 to M50 M50 to M60 M60 to M70 M70 to M80 M80 to M90 M90 to M100 M100 to M200 M200 to M300	0.2 µm 0.3 µm 0.4 µm 0.5 µm 0.6 µm 0.7 µm 0.9 µm 1 µm 1.1 µm 1.3 µm 1.4 µm 2.7 µm 4 µm	ULM / Gauge Block

Length – Dimensional Metrology

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Taper Ring Gauge	M2 to M6 M6 to M20 M20 to M30 M30 to M75 M75 to M100 M100 to M150	0.4 µm 0.5 µm 0.6 µm 2.3 µm 2.4 µm 2.9 µm	ULM / Ring Gauge
Taper Thread Plug	M2 to M5 M5 to M11 M11 to M22 M22 to M45 M45 to M180	0.92 µm 1.8 µm 1.1 µm 4.7 µm 7.6 µm	ULM / 3 Wire
¹ Coordinate Measuring Machine X, Y, Z Axis	Up to 10 mm (10 to 25) mm (25 to 50) mm (50 to 75) mm (75 to 100) mm (100 to 125) mm (125 to 150) mm (150 to 175) mm (175 to 200) mm (200 to 250) mm (250 to 300) mm (300 to 400) mm (400 to 500) mm (500 to 800) mm (800 to 1 000) mm (1 000 to 1 200) mm (1 200 to 1 500) mm	0.16 µm 0.34 µm 0.67 µm 1 µm 1.3 µm 1.7 µm 2.1 µm 2.4 µm 2.7 µm 3.4 µm 4.1 µm 5.4 µm 6.7 µm 11 µm 13 µm 16 µm 20 µm	Gauge Block
Ultrasonic Thickness Gauge	Up to 100 mm	0.006 µm	Gauge Blocks
Standard Scale	Up to 50 mm. (>50 to 200) mm. (>200 to 410) mm	1.3 µm 2.4 µm 3.4 µm	3D Vision Measuring Machine, Standard Glass Scale
Coating Thickness Gauge	(30 to 1 470) µm	0.92 µm	Calibration Foils
Square	Up to 100 mm (> 100 to 200) mm (> 200 to 300) mm (> 300 to 400) mm (> 400 to 500) mm (>500 to 700) mm	3.1 µm 3.8 µm 4.5 µm 6.0 µm 7.2 µm 9.8 µm	Coordinate Measuring Machine

Mass and Mass Related

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
¹ Electronic Balance, Spring Balance, Load Cell			
Resolution: 0.000 01 g	Up to 10 g	0.04 mg	
0.000 01 g	(10 to 20) g	0.05 mg	
0.000 01 g	(20 to 50) g	0.08 mg	
0.000 01 g	(50 to 60) g	0.11 mg	
0.000 01 g	(60 to 70) g	0.12 mg	
0.000 01 g	(70 to 100) g	0.16 mg	
0.000 1 g	(100 to 150) g	0.2 mg	
0.000 1 g	(150 to 220) g	0.3 mg	
0.000 1 g	(220 to 300) g	0.4 mg	
0.001 g	(300 to 1 000) g	1 mg	
0.001 g	(1 000 to 2 000) g	2 mg	Weight Sets (E2, F1, M1)
0.001 g	(2 to 3) kg	3 mg	
0.001 g	(3 to 5) kg	5 mg	
0.001 g	(5 to 6) kg	10 mg	
0.001 g	(6 to 8) kg	12 mg	
0.01 g	(8 to 10) kg	17 mg	
0.01 g	(10 to 12) kg	20 mg	
0.01 g	(12 to 20) kg	26 mg	
0.01 kg	(20 to 100) kg	5.8 g	
0.1 kg	(100 to 1 000) kg	58 g	
0.5 kg	(1 000 to 5 000) kg	0.33 kg	
1 kg	(5 000 to 10 000) kg	0.66 kg	
5 kg	(10 000 to 40 000) kg	3.2 kg	
10 kg	(40 000 to 80 000) kg	6.3 kg	
¹ Push-Pull Gauge, Force Gauge, Tension, Tensile	Up to 1 000 N (1 000 to 3 000) N (3 000 to 5 000) N (5 000 to 10 000) N	0.006 N 0.01 N 0.02 N 0.03 N	Weight Sets
¹ Hand Torque Tool, Torque Wrench, Torque Driver, Electronic Torque	(0.2 to 20) N·m (20 to 40) N·m (40 to 60) N·m (60 to 80) N·m (80 to 100) N·m (100 to 200) N·m (200 to 400) N·m (400 to 600) N·m (600 to 800) N·m (800 to 1 000) N·m	0.06 N·m 0.07 N·m 0.08 N·m 0.09 N·m 0.1 N·m 3.1 N·m 3.5 N·m 3.9 N·m 4.4 N·m 5 N·m	Static Torque Transducer

Mass and Mass Related

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
¹ Hardness Tester, Duro Tester Type (A, B, O) Spring Force Only	(Up to 30) Duro (30 to 40) Duro (40 to 100) Duro	0.6 Duro 0.7 Duro 0.9 Duro	Weight Sets
¹ Hardness Tester, Duro Tester Type (C, D, DO) Spring Force Only	Up to 20) Duro (20 to 30) Duro (30 to 40) Duro (40 to 50) Duro (50 to 60) Duro (60 to 70) Duro (70 to 80) Duro (80 to 90) Duro (90 to 100) Duro	1.2 Duro 2.1 Duro 2.4 Duro 2.3 Duro 2.7 Duro 3.9 Duro 4.3 Duro 6.1 Duro 6.5 Duro	Weight Sets
Manometer	(0 to 1) psi	0.007 3 psi	Pressure Module Fluke model 700PD2
¹ Pressure Gauge (Pneumatic & Hydraulic), Digital Pressure Gauge, Pressure Transducer, Differential Pressure Gauge, Pressure Transmitter, Manometer, Pressure Switch	Pneumatic gauge pressure (0 kPa to 200) kPa (> 200 to 2 000) kPa Hydraulic gauge pressure (0 to 7) MPa (> 7 to 70) MPa	0.15 kPa 1.2 kPa 23 kPa 31 kPa	Pressure Calibrator
¹ Vacuum Gauge	(-90 to 0) kPa	55 Pa	Pressure Calibrator
Mass (Standard Weights)	10 mg 20 mg 50 mg 100 mg 200 mg 500 mg 1 g 2 g 5 g 10 g 20 g 50 g 100 g 200 g 500 g	0.013 mg 0.014 mg 0.024 mg 0.026 mg 0.027 mg 0.03 mg 0.012 mg 0.014 mg 0.018 mg 0.024 mg 0.035 mg 0.087 mg 0.14 mg 0.26 mg 0.85 mg	Electronic Balance and Weight Sets (E2, F1, M1)

Mass and Mass Related

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Mass (Standard Weights)	1 kg 2 kg 5 kg 10 kg 20 kg 500 kg	2.1 mg 6.9 mg 11 mg 61 mg 69 mg 8.7 g	Electronic Balance and Weight Sets (E2, F1, M1)
Torque Calibrator	(0.1 to 2) N.m (2 to 4) N.m (4 to 6) N.m (6 to 8) N.m (8 to 10) N.m (10 to 20) N.m (20 to 40) N.m (40 to 200) N.m (200 to 400) N.m (400 to 1 000) N.m (1 000 to 1 500) N.m	0.92 % of reading 0.46 % of reading 0.31 % of reading 0.23 % of reading 0.18 % of reading 0.1 % of reading 0.05 % of reading 0.03 % of reading 0.02 % of reading 0.01 % of reading 0.006 % of reading	Weight and Calibration arm
Universal Testing Machine ¹ Crane Scales ¹ Compression / Tensile Testing Machine	Compression Testing Machine (0.10 to 200) kN Tensile Testing Machine 100 N to 30 kN	0.32 % of reading 0.16 % of reading	Standard Load cell
Volumetric Glassware Burette	5 ml 10 ml 25 ml 50 ml 100 ml	0.003 5 ml 0.003 7 ml 0.006 5 ml 0.01 ml 0.018 ml	Electronic Balance
Volumetric Glassware Volumetric Flask	2 ml 5 ml 10 ml 20 ml 25 ml 50 ml 100 ml 200 ml 250 ml 500 ml 1 000 ml	0.005 8 ml 0.005 8 ml 0.005 9 ml 0.006 2 ml 0.006 5 ml 0.01 ml 0.017 ml 0.028 ml 0.035 ml 0.063 ml 0.13 ml	Electronic Balance

Mass and Mass Related

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Volumetric Glassware Measuring Cylinder	5 ml 10 ml 25 ml 50 ml 100 ml 250 ml 500 ml 1 000 ml	0.005 8 ml 0.005 9 ml 0.006 5 ml 0.01 ml 0.017 ml 0.035 ml 0.063 ml 0.13 ml	Electronic Balance
Volumetric Glassware Measuring Pipette	0.5 ml 1 ml 2 ml 5 ml 10 ml 15 ml 25 ml 50 ml	0.002 3 ml 0.002 3 ml 0.002 3 ml 0.002 4 ml 0.003 7 ml 0.006 ml 0.006 5 ml 0.01 ml	Electronic Balance
Volumetric Glassware Volumetric Pipette	0.5 ml 1 ml 2 ml 5 ml 10 ml 15 ml 25 ml 50 ml 100 ml	0.002 3 ml 0.002 3 ml 0.002 3 ml 0.002 4 ml 0.003 7 ml 0.006 ml 0.006 5 ml 0.01 ml 0.016 ml	Electronic Balance

Thermodynamic

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
¹ Temperature Controlled Chamber, Hot Air Oven, Incubator, Refrigerator, Low Temperature Incubator, Autoclave	(-40.0 to 0) °C (0 to 100) °C (100 to 200) °C (200 to 250) °C	0.27 °C 0.19 °C 0.26 °C 0.31 °C	Agilent 34970A Data logger and Thermocouple with RTD sensor
¹ Temperature Gauge & Dial Thermometer	(-80 to 250) °C	0.07 °C	PRT Standard Hart Scientific 1575
	(250 to 500) °C (500 to 650) °C	0.7 °C 2.6 °C	Thermocouple Standard Fluke 1524

Thermodynamic

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
¹ Thermocouple Sensor TC	(-80 to 250) °C	0.07 °C	PRT Standard Hart Scientific 1575
	(250 to 500) °C (500 to 1 200) °C	0.7 °C 2.6 °C	Thermocouple Standard Fluke 1524
¹ Liquid Bath	(-40.0 to 0) °C (0 to 100) °C (100 to 200) °C (200 to 250) °C	0.27 °C 0.19 °C 0.26 °C 0.31 °C	Agilent 34970A Data logger and Thermocouple with RTD sensor
¹ Digital Thermometer with Thermocouple Sensors Types K, J, E, T, N, R, S	(-80 to 250) °C	0.07 °C	PRT Standard Hart Scientific 1575
	(250 to 500) °C (500 to 1 200) °C	0.7 °C 2.6 °C	Thermocouple Standard Fluke 1524
¹ Digital Thermometer with RTD or Thermistor Sensor	(-80 to 250) °C	0.07 °C	PRT Standard Hart Scientific 1575
	(250 to 500) °C (500 to 850) °C	0.7 °C 2.6 °C	Thermocouple Standard Fluke 1524
¹ RTD Sensor	(-80 to 250) °C	0.07 °C	PRT Standard Hart Scientific 1575
	(250 to 500) °C (500 to 850) °C	0.7 °C 2.6 °C	Thermocouple Standard Fluke 1524
Liquid in Glass Thermometers	(-80 to 250) °C	0.29 °C	PRT Standard Hart Scientific 1575
Dry Block, Dry Well	Up to 250 °C	0.07 °C	PRT Standard Fluke 1524
	(250 to 450) °C (450 to 1 200) °C	0.7 °C 2.6 °C	Thermocouple Standard
Digital Thermometer with Surface Probe	(40 to 350) °C	2.4 °C	Digital Thermometer Fluke 714 with Surface Probe
Infrared Thermometer	(-40 to 50) °C (>50 to 100) °C (>100 to 200) °C (>200 to 400) °C	0.91 °C 0.92 °C 1.5 °C 2 °C	Comparison to Radiation Thermometer $\epsilon = (0.9 \text{ to } 1.0)$, $\lambda = (8 \text{ to } 14)\mu\text{m}$
Thermo Hygrometer Temperature	(15 to 40) °C	0.5 °C	Thermo-Hygrometer model: Fluke 5020A Temp/Humidity Chamber

Thermodynamic

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Thermo Hygrometer Humidity	(30 to 50) %RH (50 to 70) %RH (70 to 90) %RH	1.6 %RH 2 %RH 2.3 %RH	Thermo-Hygrometer model: Fluke 5020A Temp/Humidity Chamber
Thermo Hygrometer Temperature Chamber	(20 to 40) °C	0.11 °C	Agilent 34901A Datalogger with RTD sensor
Thermo Hygrometer Humidity Chamber	(30 to 70) %RH	3.3 %RH	Data Logger CEM DT-172 Comparison

Time and Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Digital Tachometer	Photo Type (2.5 to 999.9) rpm (> 999.9 to 9 999.9) rpm (> 9 999.9 to 99 999) rpm	0.01 rpm 0.06 rpm 0.58 rpm	Fluke 5502A Multiproduct Calibrator with LED
	Contact Type (0.5 to 999.9) rpm (> 999.9 to 9 999.9) rpm (> 9 999.9 to 19 999) rpm	0.01 rpm 0.06 rpm 0.58 rpm	Fluke 5502A Multiproduct Calibrator
Stop watch ¹	10 s to 1 h	27 ms	Universal Counter, Agilent 53132A, Universal Frequency Counter Fluke PM6685R and Multifunction synthesizer, HP 8904A
Frequency ¹ Source	(0.01 to 500) Hz 500 Hz to 5 kHz (5 to 50) kHz	20 µHz/Hz + 5.9 mHz 20 µHz/Hz + 58 mHz 20 µHz/Hz + 0.58 Hz	Fluke 5502A Multiproduct Calibrator
³ General Frequency Source	(1 to 1 000) Hz >1Hz to 10 kHz (>0.01 to 225) MHz (>225 to 300) MHz >300 MHz to 1 GHz (>1 to 1.8) GHz (>1.8 to 18) GHz	4.4 x 10 ⁻¹⁰ f 2.4 x 10 ⁻¹⁰ f 2.4 x 10 ⁻¹⁰ f 2.4 x 10 ⁻⁹ f 7 x 10 ⁻¹⁰ f 4.2 x 10 ⁻¹⁰ f 2.7 x 10 ⁻¹⁰ f	Universal Counter Agilent 53132A, Standard Universal Frequency Counter Fluke PM 6685R and Measuring receiver HP 8902A

Time and Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Radar Gun Speed	24.150 GHz 40.25 km/h 56.35 km/h 104.65 km/h 34.7 GHz 40.64 km/h 64.75 km/h	1 km/h 1 km/h	Using Tuning Forks
¹ Radar Speed All Frequency band	60 km/h 90 km/h 120 km/h	0.4 km/h 0.6 km/h 0.9 km/h	Rasmi Racing Drag and Timer, Measuring Tape, Calculate speed (S) by known distance (D) and known elapse time (T) $S = \frac{D}{T}$
¹ Centrifuge	(50.00 to 999.99) rpm (1 000.0 to 3 000.0) rpm (3 000.1 to 9 999.9) rpm (10 000 to 20 000) rpm	0.53 rpm 1.9 rpm 5.3 rpm 13 rpm	Digital Tachometer
Universal Frequency Counter	Time Base 1 MHz to 10 MHz Frequency DC to 18 GHz Time Interval 1 μs to 1 ms Trigger Level (0 to ±5.25) V	2.4×10^{-10} 2.9×10^{-10} 0.6 ps 0.001 9 mV	Universal Counter Agilent 53131A, Universal Frequency Counter Calibrator Fluke PM6685R, RF Signal Generator Agilent N9310A, Function Generator/Arbitrary Waveform Generator Hewlett-Packard 33120A, Synthesizer Signal Generator Hewlett Packard 83731A, Multifunction Synthesizer Hewlett Packard 8904A
Time Interval Source	10 ns to 1 s (>1 to 10) s (>10 to 50) s <td>2 ns 4 ns 14 ns 26 ns</td> <td>Universal Counter Agilent 53131A, Universal Frequency Counter Calibrator Fluke PM6685R.</td>	2 ns 4 ns 14 ns 26 ns	Universal Counter Agilent 53131A, Universal Frequency Counter Calibrator Fluke PM6685R.

DIMENSIONAL MEASUREMENT

1 Dimensional

Specific Tests and / or Properties Measured	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method and/or Equipment
Jig, Fixture and Mold, Die X Axis	Up to 25 mm (25 to 50) mm (50 to 75) mm (75 to 100) mm (100 to 125) mm (125 to 150) mm (150 to 175) mm (175 to 200) mm (200 to 250) mm (250 to 300) mm (300 to 400) mm (400 to 500) mm (500 to 600) mm	0.002 7 mm 0.002 8 mm 0.002 9 mm 0.003 mm 0.003 2 mm 0.003 4 mm 0.003 6 mm 0.003 8 mm 0.004 3 mm 0.004 9 mm 0.006 mm 0.007 2 mm 0.008 5 mm	Coordinate Measuring Machine
Jig, Fixture and Mold, Die Y Axis	Up to 25 mm (25 to 50) mm (50 to 75) mm (75 to 100) mm (100 to 125) mm (125 to 150) mm (150 to 175) mm (175 to 200) mm (200 to 250) mm (250 to 300) mm (300 to 400) mm (400 to 500) mm (500 to 700) mm	0.002 7 mm 0.002 8 mm 0.002 9 mm 0.003 mm 0.003 2 mm 0.003 4 mm 0.003 6 mm 0.003 8 mm 0.004 3 mm 0.004 9 mm 0.006 mm 0.007 2 mm 0.009 8 mm	Coordinate Measuring Machine
Jig, Fixture and Mold, Die Z Axis	Up to 25 mm (25 to 50) mm (50 to 75) mm (75 to 100) mm (100 to 125) mm (125 to 150) mm (150 to 175) mm (175 to 200) mm (200 to 250) mm (250 to 300) mm (300 to 400) mm (400 to 500) mm	0.002 7 mm 0.002 8 mm 0.002 9 mm 0.003 mm 0.003 2 mm 0.003 4 mm 0.003 6 mm 0.003 8 mm 0.004 3 mm 0.004 9 mm 0.006 mm 0.007 2 mm	Coordinate Measuring Machine



Calibration and Measurement Capability (CMC) is expressed in terms of the measurement parameter, measurement range, expanded uncertainty of measurement and reference standard, method, and/or equipment. The expanded uncertainty of measurement is expressed as the standard uncertainty of the measurement multiplied by a coverage factor of 2 ($k=2$), corresponding to a confidence level of approximately 95%.

Notes:

1. On-site calibration service is available for this parameter, since on-site conditions are typically more variable than those in the laboratory, larger measurement uncertainties are expected on-site than what is reported on the accredited scope.
2. Nominal values listed are approximate.
3. f = frequency in Hz.
4. Mismatch Uncertainty is based on DUT SWR: 1.4 for <2 GHz; 1.6 for <18 GHz
5. This scope is formatted as part of a single document including Certificate of Accreditation No. ACT-2050.



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